Se	Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/708,847	YAN, HAI		
Examiner	Art Unit		
Helen C. Kwok	2856		

	SEARCHED				
Class	Subclass	Date	Examiner		
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
73	504.04	3/22/2005	. HK		
73	504.14	3/22/2005	НК		

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